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Team Nexperia



30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor Rev. 01 — 27 January 2010

Product data sheet

1. **Product profile**

1.1 General description

PNP low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT457 (SC-74) small Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS4032ND.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- Optimized switching time
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High energy efficiency due to less heat generation
- AEC-Q101 qualified
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- DC-to-DC conversion
- Battery-driven devices
- Power management
- Charging circuits

1.4 Quick reference data

Table 1. **Quick reference data**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	-30	V
l _C	collector current		-	-	-2.7	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 \text{ ms}$	-	-	-5	A
R _{CEsat}	collector-emitter saturation resistance	I _C = -3 A; I _B = -300 mA	<u>[1]</u> _	88	130	mΩ

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30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

2. Pinning information

Table 2.	Pinning				
Pin	Description	Simplified outline	Graphic symbol		
1	collector				
2	collector		1, 2, 5, 6		
3	base	0	3		
4	emitter		 4		
5	collector		4 sym030		
6	collector				

3. Ordering information

Table 3. Orde	able 3. Ordering information		
Type number	Package		
	Name	Description	Version
PBSS4032PD	SC-74	plastic surface-mounted package; 6 leads	SOT457

4. Marking

Table 4. Marking codes	
Type number	Marking code
PBSS4032PD	ZG

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CBO}	collector-base voltage	open emitter	-	-30	V
V _{CEO}	collector-emitter voltage	open base	-	-30	V
V _{EBO}	emitter-base voltage	open collector	-	-5	V
I _C	collector current		-	-2.7	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 \text{ ms}$	-	-5	A
I _B	base current		-	-0.5	А

30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

Table 5.	Limiting v	alues continu	Jed
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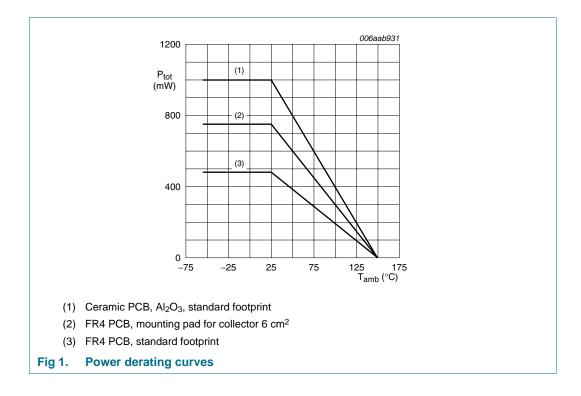
In accordance with the Absolute Maximum Rating System (IEC 60134).

				,		
Symbol	Parameter	Conditions		Min	Мах	Unit
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$	[1]	-	480	mW
			[2]	-	750	mW
			[3]	-	1	W
Tj	junction temperature			-	150	°C
T _{amb}	ambient temperature			-55	+150	°C
T _{stg}	storage temperature			-65	+150	°C

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

[3] Device mounted on a ceramic PCB, AI_2O_3 , standard footprint.



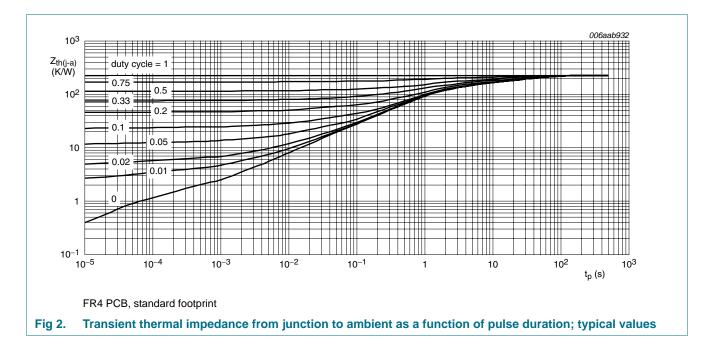
30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)} thermal resistance from junction to ambient	thermal resistance from	in free air	<u>[1]</u> -	-	260	K/W
	junction to ambient		[2] _	-	160	K/W
			<u>[3]</u> _	-	125	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point		-	-	45	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

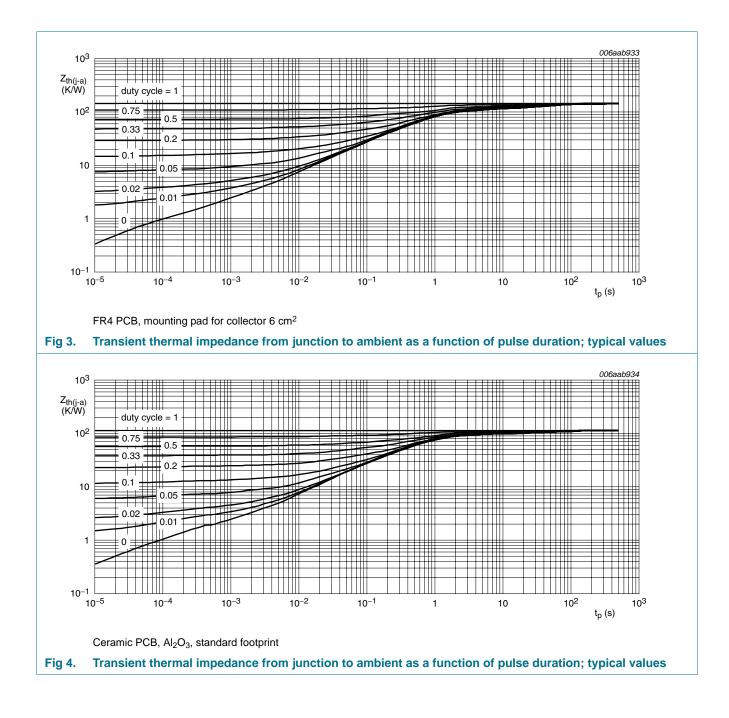
[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².



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PBSS4032PD

30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor



30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

7. Characteristics

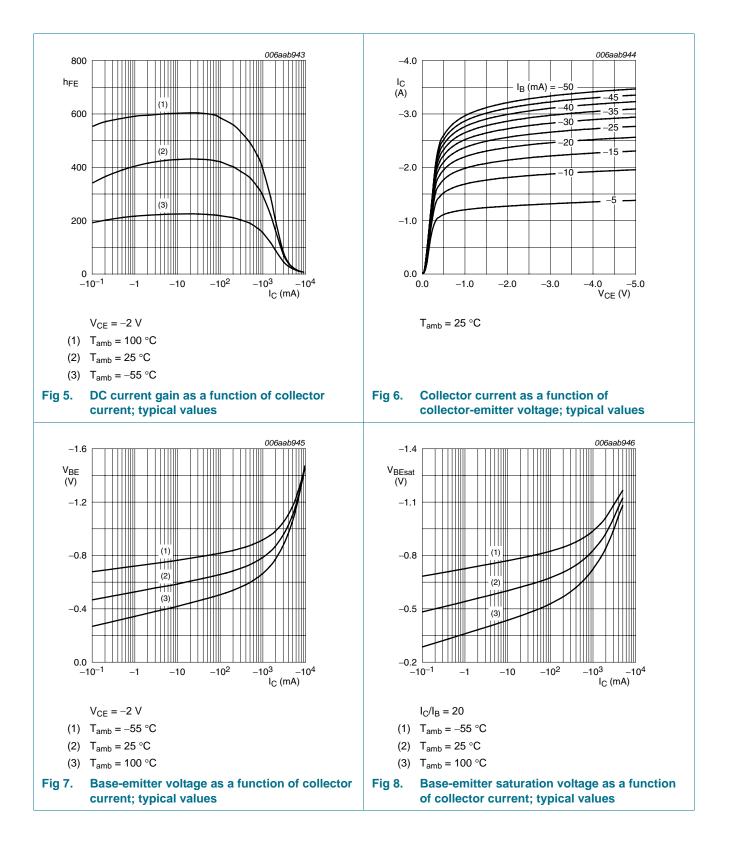
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = -30 \text{ V}; I_E = 0 \text{ A}$		-	-	-100	nA
	current	$V_{CB} = -30 \text{ V}; I_E = 0 \text{ A};$ T _j = 150 °C		-	-	-55	μA
I _{CES}	collector-emitter cut-off current	$V_{CE} = -24 \text{ V}; V_{BE} = 0 \text{ V}$		-	-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; \text{ I}_{C} = 0 \text{ A}$		-	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -2 V;$ $I_{C} = -500 \text{ mA}$	<u>[1]</u>	200	350	-	
		$V_{CE} = -2 \text{ V}; \text{ I}_{C} = -1 \text{ A}$	[1]	200	300	-	
		$V_{CE} = -2 \text{ V}; \text{ I}_{C} = -2 \text{ A}$	[1]	100	160	-	
	$V_{CE} = -2 \text{ V}; \text{ I}_{C} = -4 \text{ A}$	[1]	25	40	-		
V _{CEsat} collector-emitter saturation voltage	$I_{C} = -500 \text{ mA};$ $I_{B} = -50 \text{ mA}$		-	-87	-130	mV	
		$I_{C} = -1 \text{ A}; I_{B} = -50 \text{ mA}$	[1]	-	-140	-210	mV
		$I_{\rm C} = -1$ A; $I_{\rm B} = -10$ mA	[1]	-	-205	-300	mV
		$I_{C} = -2 \text{ A}; I_{B} = -40 \text{ mA}$	[1]	-	-280	-420	mV
		$I_{\rm C} = -2$ A; $I_{\rm B} = -200$ mA	[1]	-	-170	-255	mV
		$I_{C} = -3 \text{ A}; I_{B} = -300 \text{ mA}$	[1]	-	-265	-395	mV
R _{CEsat}	collector-emitter saturation resistance	$I_{C} = -3 \text{ A}; I_{B} = -300 \text{ mA}$	<u>[1]</u>	-	88	130	mΩ
V _{BEsat}	base-emitter	$I_{C} = -1 \text{ A}; I_{B} = -100 \text{ mA}$	[1]	-	-0.83	-0.9	V
	saturation voltage	$I_{C} = -3 \text{ A}; I_{B} = -300 \text{ mA}$	[1]	-	-1.11	-1.2	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; \text{ I}_{C} = -2 \text{ A}$		-	-0.85	-0.95	V
t _d	delay time	$V_{CC} = -12.5 V;$		-	20	-	ns
t _r	rise time	$I_{C} = -1 \text{ A}; I_{Bon} = -0.05 \text{ A};$ $I_{Boff} = 0.05 \text{ A}$		-	55	-	ns
t _{on}	turn-on time	- IBoff = 0.05 A		-	75	-	ns
t _s	storage time			-	130	-	ns
t _f	fall time			-	80	-	ns
t _{off}	turn-off time			-	210	-	ns
f _T	transition frequency	$V_{CE} = -10 \text{ V};$ $I_{C} = -100 \text{ mA};$ f = 100 MHz		-	104	-	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V};$ $I_E = i_e = 0 \text{ A}; \text{ f} = 1 \text{ MHz}$		-	59	-	pF

[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02.$

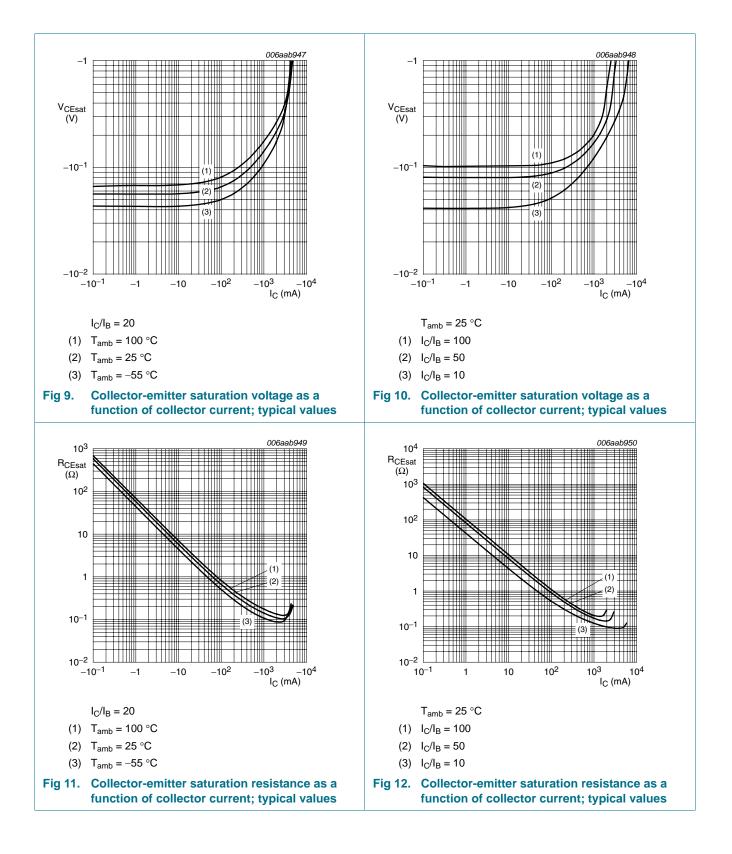
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30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

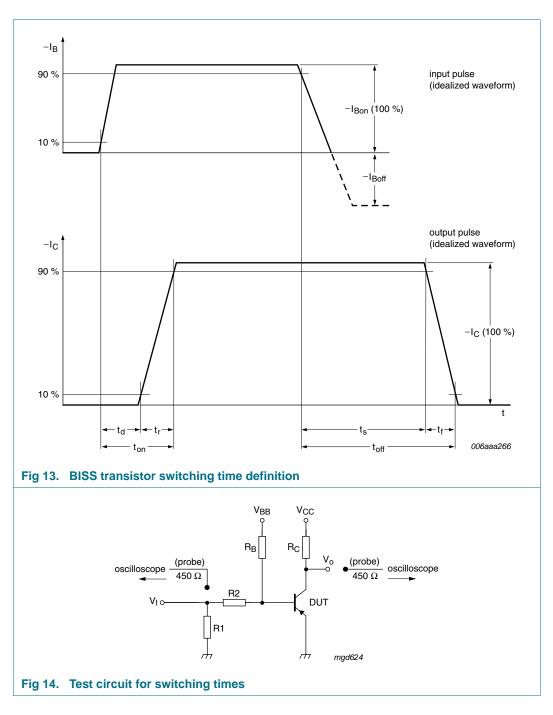


30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor



30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

8. Test information

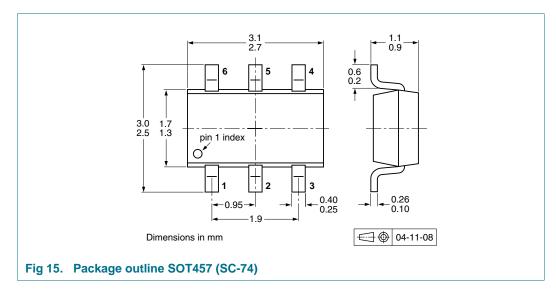


8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description		Packing quantity	
				3000	10000
PBSS4032PD	SOT457	4 mm pitch, 8 mm tape and reel	[2]	-115	-135
		4 mm pitch, 8 mm tape and reel	[3]	-215	-235

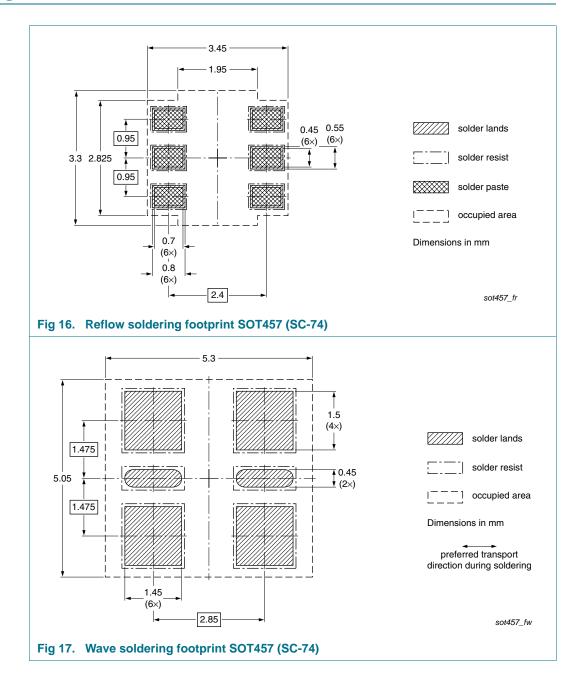
[1] For further information and the availability of packing methods, see <u>Section 14</u>.

[2] T1: normal taping

[3] T2: reverse taping

30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

11. Soldering



30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

12. Revision history

Table 9. Revision hist	tory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS4032PD_1	20100127	Product data sheet	-	-

30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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PBSS4032PD_1 Product data sheet

30 V, 2.7 A PNP low V_{CEsat} (BISS) transistor

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Date of release: 27 January 2010 Document identifier: PBSS4032PD_1

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